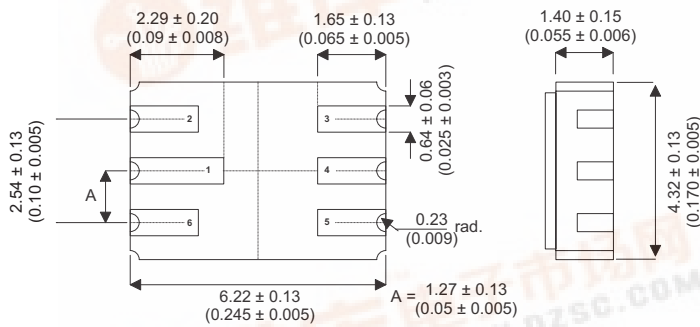


# 2N2916DCSM

## MECHANICAL DATA

Dimensions in mm (inches)



### LCC2 PACKAGE Underside View

- PAD 1 – Collector 1
- PAD 2 – Base 1
- PAD 3 – Base 2
- PAD 4 – Collector 2
- PAD 5 – Emitter 2
- PAD 6 – Emitter 1

## DUAL NPN PLANAR TRANSISTORS IN A HERMETICALLY SEALED CERAMIC SURFACE MOUNT PACKAGE FOR HIGH RELIABILITY APPLICATIONS

### FEATURES

- Hermetic Ceramic Surface Mount Package
- CECC Screening Options
- Space Quality Levels Options

## ABSOLUTE MAXIMUM RATINGS

( $T_{amb} = 25^{\circ}C$  unless otherwise stated)

		EACH SIDE	TOTAL DEVICE
$V_{CBO}$	Collector – Base Voltage	45V	
$V_{CEO}$	Collector – Emitter Voltage <sup>1</sup>	45V	
$V_{EBO}$	Emitter – Base Voltage	6V	
$I_C$	Continuous Collector Current	30	
$P_D$	Total Device Dissipation	$T_{AMB} = 25^{\circ}C$	300mW
		Derate above $25^{\circ}C$	500mW
		1.72mW / $^{\circ}C$	2.86W / $^{\circ}C$
$T_{STG}$	Storage Temperature Range	-65 to $200^{\circ}C$	
$T_L$	Lead temperature (Soldering, 10 sec.)	300 $^{\circ}C$	

### NOTES

<sup>1</sup> Base – Emitter Diode Open Circuited.

**ELECTRICAL CHARACTERISTICS** ( $T_{amb} = 25^{\circ}\text{C}$  unless otherwise stated)

Parameter	Test Conditions <sup>1</sup>	Min.	Typ.	Max.	Unit	
<b>INDIVIDUAL TRANSISTOR CHARACTERISTICS</b>						
$V_{(BR)CBO}$	Collector – Base Breakdown Voltage	$I_C = 10\text{mA}$	$I_E = 0$	45	V	
$V_{(BR)CEO}^*$	Collector – Emitter Breakdown Voltage	$I_C = 10\text{mA}$	$I_B = 0$	45		
$V_{(BR)EBO}$	Emitter – Base Breakdown Voltage	$I_E = 10\text{mA}$	$I_C = 0$	6		
$I_{CBO}$	Collector Cut-off Current	$V_{CB} = 45\text{V}$	$I_E = 0$		10	nA
			$T_A = 150^{\circ}\text{C}$			10
$I_{CEO}$	Collector Cut-off Current	$V_{CE} = 5\text{V}$	$I_B = 0$		2	nA
$I_{EBO}$	Emitter Cut-off Current	$V_{EB} = 5\text{V}$	$I_C = 0$		2	
$h_{FE}$	DC Current Gain	$V_{CE} = 5\text{V}$	$I_C = 10\text{mA}$	150	600	—
			$T_A = -55^{\circ}\text{C}$	30		
		$I_C = 100\text{mA}$	225			
		$I_C = 1\text{mA}$	300			
$V_{BE}$	Base – Emitter Voltage	$V_{CE} = 5\text{V}$	$I_C = 100\text{mA}$		0.70	V
$V_{CE(sat)}$	Collector – Emitter Saturation Voltage	$I_B = 100\text{mA}$	$I_C = 1\text{mA}$		0.35	
$h_{ib}$	Small Signal Common – Base Input Impedance	$V_{CB} = 5\text{V}$ $f = 1\text{kHz}$	$I_C = 1\text{mA}$	25	32	$\Omega$
$h_{ob}$	Small Signal Common – Base Output Admittance	$V_{CB} = 5\text{V}$ $f = 1\text{kHz}$	$I_C = 1\text{mA}$		1	$\mu\text{mho}$
$ h_{fe} $	Small Signal Common – Base Current Gain	$V_{CE} = 5\text{V}$ $f = 20\text{MHz}$	$I_C = 500\text{mA}$	3		—
$C_{obo}$	Common – Base Open Circuit Output Capacitance	$V_{CB} = 5\text{V}$ $f = 140\text{kHz to } 1\text{MHz}$	$I_E = 0$		6	pF
<b>TRANSISTOR MATCHING CHARACTERISTICS</b>						
$\frac{h_{FE1}}{h_{FE2}}$	Static Forward Current Gain Balance Ratio	$V_{CE} = 5\text{V}$ See Note 2.	$I_C = 100\mu\text{A}$	0.9	1	—
$ V_{BE1} - V_{BE2} $	Base – Emitter Voltage Differential	$V_{CE} = 5\text{V}$	$I_C = 100\mu\text{A}$		3	mV
		$V_{CE} = 5\text{V}$	$I_C = 10\mu\text{A to } 1\text{mA}$		5	
$ D(V_{BE1} - V_{BE2})DT_A $	Base – Emitter Voltage Differential Change With Temperature	$V_{CE} = 5\text{V}$	$I_C = 100\mu\text{A}$		0.8	mV
		$T_{A1} = 25^{\circ}\text{C}$	$T_{A2} = -55^{\circ}\text{C}$			
		$V_{CE} = 5\text{V}$	$I_C = 100\mu\text{A}$		1	
		$T_{A1} = 25^{\circ}\text{C}$	$T_{A2} = 125^{\circ}\text{C}$			

\* Pulse Test:  $t_p = 300\mu\text{s}$ ,  $\delta \leq 1\%$ .

**NOTES**

- 1) Terminals not under test are open circuited under all test conditions.
- 2) The lower of the two readings is taken as  $h_{FE1}$ .